TOSHIBA Diodes for Protecting against ESD Epitaxial Planar Type

DF3A3.3FV

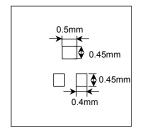
Diodes for Protecting against ESD

- The mounting of two devices on an ultra-compact package reduces the number of parts and lowers assembly cost.
- The zener voltage corresponds to that of the E24 Series.

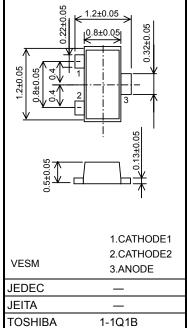
Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Power dissipation	P*	150	mW
Junction temperature	Tj	150	°C
Storage temperature range	T _{stg}	−55 ~ 150	°C

^{*:} Mounted on FR4 board (25.4 mm × 25.4 mm × 1.6 mmt)



Unit: mm



Weight: 0.0015g (typ.)

Electrical Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Zener voltage	VZ	$I_Z = 5 \text{ mA}$	3.1	3.3	3.5	V
Dynamic impedance	Z _Z	$I_Z = 5 \text{ mA}$	_	_	130	Ω
Reverse current	I _R	V _R = 1.5 V	_	_	100	μА
Terminal capacitance (between Cathode and Anode)	C _T	V _R = 0, f = 1MHz	ı	115	_	pF

Guaranteed Level of ESD Immunity

Test Condition	ESD Immunity Level
IEC61000-4-2 (Contact discharge)	± 30 kV

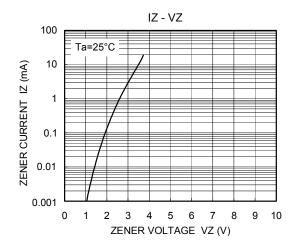
Criterion: No damage to device elements

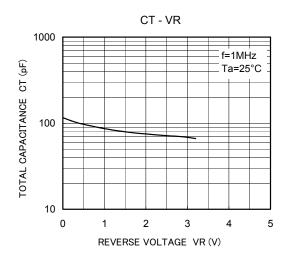
Marking

Equivalent Circuit (top view)









2004-06-25

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